

**Search Notes**

Application/Control No.

10/660,386

Examiner

EDMUND H. LEE

Applicant(s)/Patent under  
Reexamination

SZCZESUIL ET AL.

Art Unit

1732

**SEARCHED**

| Class   | Subclass | Date      | Examiner |
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| UPDATED |          | 12/8/2005 | EHL      |
| 264     | 259      |           |          |
|         | 241      |           |          |
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**INTERFERENCE SEARCHED**

| Class | Subclass | Date      | Examiner |
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| 264   | 259,241  | 12/8/2005 | EHL      |
|       | 293      |           |          |
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**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

|         | DATE      | EXMR |
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| UPDATED | 12/8/2005 | EHL  |
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